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An early and favorable action on the merits is respectfully requested.

By:

Grand Hotel

Enc.: Substitute Specification
Substitute Abstract of the Disclosure
Marked-up Versions

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Title of Invention:	FLUORESCENCE MICROSCOPE		
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MARKED-UP / BOLDDED
VERSIONS OF THE
SUBSTITUTE
SPECIFICATION
AND
ABSTRACT

Docket No.: GK-ZEI-3152/500343.20153

FLUORESCENCE MICROSCOPE

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CROSS-REFERENCE TO RELATED APPLICATIONS

This application claims priority of PCT Application Serial
No. PCT/EP01/07104 filed June 22, 2001 and German Application No.100 30
929.1 filed June 26, 2000, the complete disclosures of which are hereby
10 incorporated by reference.

BACKGROUND OF THE INVENTION

a) Field of the invention

The present invention relates to microscopes equipped for
15 handling fluorescence applications.

b) Description of the Related Art

A known microscope for fluorescence applications is shown in
Fig. 1. The beam path in a microscope equipped for fluorescence applications is
20 shown in that figure.

[Fig. 1 shows the beam path in a microscope equipped for
fluorescence applications.] The light from an additional light source (1) passes
through a heat-absorbing filter (2), red attenuating filter/stop slide (3) and a field
diaphragm (4) to the excitation filter (5). The latter is installed in the reflector slide
of the microscope which also contains a dichroic beam splitter (6). The dichroic
25 beam splitter reflects the shortwave excitation light through the objective (7) into the
specimen or preparation (8).

The occurring emission is collected by the objective (7) and - because
it has greater wavelengths than the excitation light - is passed by the dichroic beam
splitter (6). The beams now pass through the emission filter (9). The remainder of
30 the excitation light is filtered out by the latter. For this reason, this filter is also

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referred to as a blocking filter. As is conventional, the tube lens (10) and eyepiece (11) form the microscope image formed of fluorescent light.

The Problem Addressed by the Invention

5 In order to avoid image offset (pixel shift), multiple exposures in fluorescence recordings with different emission filter sets (A, B) require an optimal congruence of the object image in the individual recordings. However, there are technological limits in this respect.

10 Because of the different wedge angles of the emission filters (A_{Em} , B_{Em}) and of the color splitters, the filter combinations needed for the fluorescence application cause a slight image offset. This is shown in Fig. 2.

The reference symbols have the following meanings:

	A_{Em}	emission filter of filter set A
15	B_{Em}	emission filter of filter set B
	a_1	light beam striking A_{Em}
	b_1	light beam striking B_{Em}
	a_2	light beam deflected by A_{Em}
	b_2	light beam deflected by B_{Em}
20	α_A	angle between the incident light beam a_1 and the deflected light beam a_2 of filter A_{Em}
	α_B	angle between the incident light beam b_1 and the deflected light beam b_2 of filter B_{Em}
	E	image plane
25	$p_A p_B$	distance (pixel shift) between the image points impinging on the image plane E

The light beams a_1 and b_1 impinge on the emission filters A_{Em} and B_{Em} of the corresponding filter sets A and B. The beam is deflected in more or less

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opposite directions because of the existing wedge angle of the filters depending on the installed position (a_2 and b_2 are greatly exaggerated in the drawing in order to illustrate the process). Therefore, the image points impinging on the image plane E do not lie exactly one above the other, but are offset relative to one another by the pixel shift. Even with the close tolerances of the filters sets by Carl Zeiss with a slight image offset, this offset still occurs to a slight extent.

OBJECT AND SUMMARY OF THE INVENTION

The object of the invention is to overcome the slight image offsets caused by different wedge angles of emission filters and color splitters in a fluorescence microscope.

In accordance with the invention, a fluorescence microscope with blocking filters for a portion of the light emitted by a specimen are marked with respect to the orientation of their wedge angle.

BRIEF DESCRIPTION OF THE DRAWINGS

In the drawings:

Fig. 1 is a schematic illustration of a fluorescence microscope;

Fig. 2 is a diagrammatic view of how the different wedge angles of the emission filters and of the color splitters cause a slight image offset; and

Fig. 3 is a diagrammatic view of how the filters are aligned with one another with respect to their wedge angle.

DESCRIPTION OF THE PREFERRED EMBODIMENTS

According to the invention, as is shown in Fig. 3, the filters are aligned with one another with respect to their wedge angle. The filters are measured and marked by the microscope manufacturer beforehand with respect to wedge angle and orientation, for example, in an autocollimator, e.g., by means of a line S on the side which can be arranged, e.g., on the side located opposite the deflecting direction

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through the wedge effect. When the filter is inserted into the respective filter module of the microscope, this filter module also has a marking which is made to coincide with the marking on the filter. Identical orientation of the filters is ensured in this way.

5 After the emission filters A_{Em} and B_{Em} are swiveled in (see Fig. 1), the impinging light beams a_1 and b_1 are deflected in the same direction (a_2 and b_2). In this way, the pixel shift which exists to a slight extent in any case is minimized or, ideally, compensated (pixel shift $\overline{p_A p_B}$).

10 In this connection, the wedge angles can also be determined on the part of the manufacturer and filters with identical wedge angles can be marked and correlated by the user

15 **While the foregoing description and drawings represent the present invention, it will be obvious to those skilled in the art that various changes may be made therein without departing from the true spirit and scope of the present invention.**

ABSTRACT OF THE DISCLOSURE

5 Fluorescence microscope with blocking filters for a portion of the
light emitted by a specimen have markings referring to the orientation of their wedge
angle. A marking to which the marking on the filter can be oriented in a defined
manner is preferably provided on the filter holder of the microscope, the filters being
marked with respect to their wedge angle.